DATA SHEET



MOS FIELD EFFECT TRANSISTOR 2SK2159

N-CHANNEL MOS FET FOR HIGH-SPEED SWITCHING

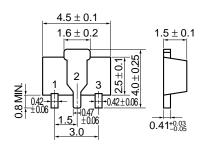
The 2SK2159 is an N-channel vertical type MOS FET featuring an operating voltage as low as 1.5 V. Because it can be driven on a low voltage and it is not necessary to consider driving current, the 2SK2159 is suitable for driving actuators of low-voltage portable systems such as headphone stereo sets and camcorders.

FEATURES

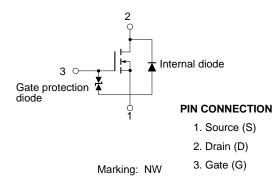
Capable of drive gate with 1.5 V

• Small RDS(on) RDS(on) = 0.7 Ω MAX. @VGS = 1.5 V, ID = 0.1 A RDS(on) = 0.3 Ω MAX. @VGS = 4.0 V, ID = 1.0 A

PACKAGE DIMENSIONS (in millimeters)



EQUIVALENT CIRCUIT

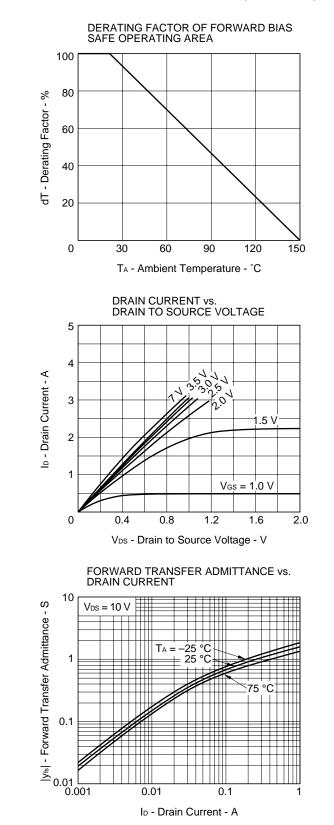


ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

PARAMETER	SYMBOL	TEST CONDITIONS	RATINGS	UNIT
Drain to Source Voltage	Vdss	V _{GS} = 0	60	V
Gate to Source Voltage	Vgss	V _{DS} = 0	±14	V
Drain Current (DC)	ID(DC)		±2.0	А
Drain Current (pulse)	D(pulse)	PW ≤ 10 ms, Duty Cycle ≤ 50 %	±4.0	A
Total Power Dissipation	Рт	Mounted on 16 $\mbox{cm}^2 \times 0.7$ mm ceramic substrate.	2.0	W
Channel Temperature	Tch		150	°C
Storage Temperature	Tstg		-55 to +150	°C

ELECTRICAL CHARACTERISTICS (T_A = 25 °C)

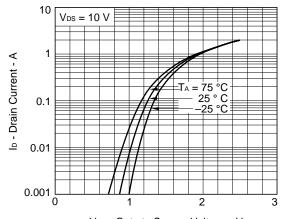
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain Cut-off Current	loss	$V_{DS} = 60 V, V_{GS} = 0$			1.0	μΑ
Gate Leakage Current	lgss	$V_{GS} = \pm 14 \text{ V}, \text{ V}_{DS} = 0$			±10	μΑ
Gate Cut-off Voltage	VGS(off)	$V_{DS} = 10 V, I_{D} = 1 mA$	0.5	0.9	1.1	V
Forward Transfer Admittance	y _{fs}	V _{DS} = 10 V, I _D = 1.0 A	0.4			S
Drain to Source On-state Resistance	RDS(on)1	Vgs = 1.5 V, Id = 0.1 A		0.55	0.7	Ω
Drain to Source On-state Resistance	RDS(on)2	Vgs = 2.5 V, Id = 1.0 A		0.27	0.5	Ω
Drain to Source On-state Resistance	RDS(on)3	Vgs = 4.0 V, Id = 1.0 A		0.22	0.3	Ω
Input Capacitance	Ciss	$V_{DS} = 10 V, V_{GS} = 0,$		319		pF
Output Capacitance	Coss	f = 1.0 MHz		109		pF
Reverse Transfer Capacitance	Crss			22		pF
Turn-On Delay Time	td(on)	$\begin{split} V_{DD} &= 25 \ V, \ I_{D} = 1.0 \ A \\ V_{GS(on)} &= 3 \ V, \ R_{G} = 10 \ \Omega \\ R_{L} &= 25 \ \Omega \end{split}$		38		ns
Rise Time	tr			128		ns
Turn-Off Delay Time	td(off)			237		ns
Fall Time	tŕ			130		ns



TYPICAL CHARACTERISTICS ($T_A = 25$ °C)

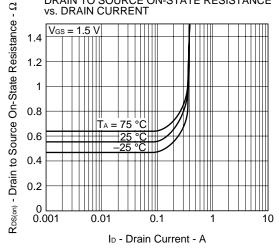
FORWARD BIAS SAFE OPERATING AREA 10 Single pulse 5 7 Ip - Drain Current - A 2 1 0.5 0.2 0.1 2 20 100 1 5 10 50 VDS - Drain to Source Voltage - V

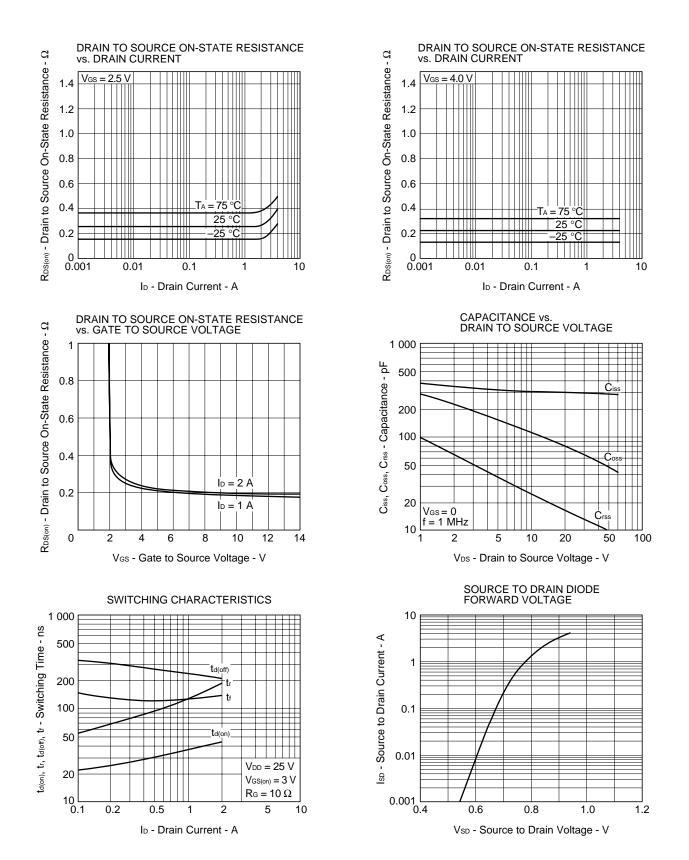
TRANSFER CHARACTERISTICS



VGS - Gate to Source Voltage - V

DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT





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REFERENCE

Document Name	Document No.		
NEC semiconductor device reliability/quality control system	TEI-1202		
Quality grade on NEC semiconductor devices	IEI-1209		
Semiconductor device mounting technology manual	C10535E		
Guide to quality assurance for semiconductor devices	MEI-1202		
Semiconductor selection guide	X10679E		

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Special: Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support)

Specific: Aircrafts, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems or medical equipment for life support, etc.

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Anti-radioactive design is not implemented in this product.

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